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- Background
- Static representation via Slugs
- Parametric representation via Plugs
- Summary and availability

- Many analysis and design tasks start from a previous configuration that is (unfortunately) defined by tessellated surfaces
 - these definitions sometimes come from legacy CAD tools that are no longer supported
 - these definitions sometimes come from laser scans of a real configuration
- This results in faceted surfaces that yield less-than-desirable results when used in CFD and FEM tools

Process The Slugs Process

- Import the cloud of points by:
 - inputting a completely disconnected set of points
 - extracting the points (and triangles) from an STL file
 - reading an IGES or STEP file and tessellating the trimmed surfaces
- Separate the points into "colors", where each color represents a part of a component
 - all colors should be bounded by 2, 3, or 4 sides
- Create Boundary Representation (Brep) with:
 - Nodes at any location where the adjacent triangles have more than 2 colors
 - Edges at any location where the adjacent triangles have only two colors and are least-square-fit with B-spline curves
 - Faces in the regions of a single color (with 2, 3, or 4 Edges) and are least-square-fit with B-spline surfaces

P Initial (uncolored) wing-body configuration



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- Is easiest when points are connected with triangles
- Mark triangle sides with "creases" (where dihedral angle exceeds a user-specified tolerance)
- Mark triangle sides on shortest side-path between two points
- Scribe triangles on "straight" line between two points and mark the new sides

SP Creases Detected and Marked



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Sides along "straight" Side-paths Marked



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EP Triangles Scribed and Side-paths Marked



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SP Advantages and Disadvantages of Slugs

• Advantages

- no need to start with a parametric model
- can be applied to a single Edge or Face
- fitting process is very fast
- Disadvantages
 - produces a non-parametric (static) model
 - coloring points can be time-consuming
 - Faces are limited to 2-, 3-, or 4-sides (no trimming)

SP The Plugs Process

- Generate a parametric model, with several design parameters (DESPMTRs);
- Phase 1: Change the DESPMTRs so that the bounding boxes of the cloud of points and the model match;
- Mark all the points in the cloud as unclassified;
- O Phase 2: Perform several passes:
 - For each point in the cloud
 - determine to which Face (if any) it should be classified
 - if no cloud points are classified differently than in the previous pass, stop Phase 2
 - Modify the DESPMTRs to least-squares minimize the distances between the classified cloud points and their respective Faces.
 - uses Levenberg-Marquardt technique
 - Go back for next Phase 2 pass

SP Initial Configuration with 15 **DESPMTR**s



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EP Initial Configuration with Cloud of Points



SP Configuration After Phase 1



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SP Configuration After Pass 1 of Phase 2



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Sep Configuration After Pass 2 of Phase 2



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Sep Configuration After Pass 3 of Phase 2



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SP Advantages and Disadvantages of Plugs

- Advantages
 - produces a parametric model
 - points do not need to be classified
 - fitting process is very fast
- Disadvantages
 - user must start with a parametric model that is "close-enough" to the cloud of points

Summary and Availability

- Given a cloud of points:
 - Slugs can be used to generate a static (non-parameterized) model
 - Plugs can be used to adjust design parameters to match the unclassified points
- Both tools are part of the ESP distribution, which is an open-source project (using the LGPL 2.1 license) that is distributed as source, and is available from https://acdl.mit.edu/ESP.